# PTC93528T19

# **SMD Type Phototransistor**

### Features

- Small double-end package
- High photo sensitivity
- High reliability
- Spectral range of sensitivity: 400-1100nm
- Fast Response time
- RoHS compliance

# Applications

Infrared sensor

### Description

**Schematic** 

The PTC93528T19 is silicon NPN Phototransistor The device has wide spectral sensitivity range from 400 to 1100nm.

## Package Outline



Collector

Emitter



# Absolute Maximum Rating at 25°C

Symbol	Parameters	Ratings	Units	Notes
lc	Collector Current	20	mA	
BVCEO	Collector-Emitter Voltage	35	V	1
B <sub>VECO</sub>	Emitter-Collector Voltage	5	V	2
T <sub>opr</sub>	Operating Temperature	-40 ~ +85	0C	
T <sub>stg</sub>	Storage Temperature	-40 ~ +100	0 <b>C</b>	
T <sub>sol</sub>	Soldering Temperature	260	0C	3
Pto	Total Power Dissipation	150	mW	

### **Optical Characteristics**

Symbol	Parameters	Test Conditions	Min	Тур	Max	Units	Notes
λ	Spectral Bandwidth	-	400	-	1100	nm	
λP	Peak Sensitivity	-	-	940	-	nm	
θ1/2	View Angle	V <sub>CE</sub> =5V	-	±50	-	deg	

### **Electrical Characteristics**

Symbol	Parameters	Test Conditions	Min	Тур	Max	Units	Notes
Iceo	Dark Current	Ee=0mW /cm <sup>2</sup>		-	100	nA	
		V <sub>CE</sub> =20V	-				
V <sub>CE(sat)</sub>	Collector-Emitter	Ee=1mW /cm <sup>2</sup>	-	-	0.4	V	
	Saturation Voltage	Ic=1.0mA					
lc	Collector Light Current	Ee=1mW /cm <sup>2</sup>	1.4	1.9	-	mA	
		$\lambda_P=940$ nm, V <sub>CE</sub> =5V					
Ст	Terminal Capacitance	Ee=0mW /cm <sup>2</sup>	-	4.4	-		
		f=1MHz ,V <sub>CE</sub> =5V				ρr	



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#### **Switching Characteristics**

Symbol	Parameters	Test Conditions	Min	Тур	Max	Units	Notes
tr	Rise Time		-	5	-		
t <sub>f</sub>	Fall Time	$V_{ce} = 5V, R_L = 100\Omega$	-	6	-		4
t <sub>on</sub>	Turn on Delay Time	Ic=1.0mA	-	5.5	-	μs	4
t <sub>off</sub>	Turn off Delay Time		-	7.5	-		

#### Notes:

- 1 : Test conditions : I\_c=100 $\mu$ A, Ee=0mW/cm<sup>2</sup>.
- 2 : Test conditions : I\_E=100 $\mu$ A, Ee=0mW/cm<sup>2</sup>.
- 3 : Soldering time  $\leq$  5 seconds.
- 4 : Test circuit :

#### Detector



Switching Time



# **Typical Characteristic Curves**



10

10

100



# **Typical Characteristic Curves**







### Package Dimension All dimensions are in mm, unless otherwise stated

Recommended Soldering Mask All dimensions are in mm, unless otherwise stated



# **Ordering Information**

Part Number	Description	Quantity
PTC93528T19	Tape & Reel	2000 pcs



Reel Dimension All dimensions are in mm, unless otherwise stated



### Tape Dimension All dimensions are in mm, unless otherwise stated





## **Reflow Profile**



Profile Feature	Pb-Free Assembly Profile		
Temperature Min. (Tsmin)	150°C		
Temperature Max. (Tsmax)	200°C		
Time (ts) from (Tsmin to Tsmax)	60-120 seconds		
Ramp-up Rate (t <sub>L</sub> to t <sub>P</sub> )	3°C/second max.		
Liquidous Temperature (TL)	217°C		
Time (t <sub>L</sub> ) Maintained Above (T <sub>L</sub> )	60 – 150 seconds		
Peak Body Package Temperature	260°C +0°C / -5°C		
Time (t <sub>P</sub> ) within 5°C of 260°C	30 seconds		
Ramp-down Rate $(T_P \text{ to } T_L)$	6°C/second max		
Time 25°C to Peak Temperature	8 minutes max.		



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